S	Sear	ch	Note	es	

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/528,528	AHN, HEE-JUNG	
Examiner	Art Unit	
Nicholas D. Rosen	3625	

Nicholas D. Rosen

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	SEAR	CHED	
Class	Subclass	Date	Examiner
705	26	11/9/2007	NDR
705	26	12/3/2007	NDR
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEA	I NOTES RCH STRATEGY)	
	DATE	EXMR
EIC search results	10/23/2007	NDR
WEST keyword search	11/9/2007	NDR
WEST keyword search	11/10/2007	NDR
WEST keyword search	11/12/2007	NDR
WEST keyword search	11/13/2007	NDR
WEST keyword search	12/3/2007	NDR
WEST keyword search	12/5/2007	NDR